

Notice of References Cited

Application/Control No.

10/649,875

Applicant(s)/Patent Under

Reexamination

YAMAGUCHI ET AL.

Examiner

Christopher M. Keehan

Art Unit

1712

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,277,485 B1	08-2001	Invie et al.	428/336
	B	US-5,763,061	06-1998	Ochiai et al.	428/215
	C	US-			
	D	US-			
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	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
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	S					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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